

IC: 5228A-DRM01

5 TEST CONDITIONS AND RESULTS

5.1 AC power line conducted emissions

For test instruments and accessories used see section 6 Part A 4.

5.1.1 Description of the test location

Test location: Shielded Room S2

5.1.2 Photo documentation of the test set-up





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5.2 Emission bandwidth

For test instruments and accessories used see section 6 Part MB.

5.2.1 **Description of the test location**

AREA4 Test location:

5.2.2 Photo documentation of the test set-up



5.2.3 Applicable standard

According to FCC Part 15, Section 15.247(a)(2): Systems using digital modulation techniques may operate in the 902 - 928 MHz, 2400 - 2483.5 MHz and 5725 – 5850 MHz bands. The minimum 6 dB bandwidth shall be at least 500 kHz.

5.2.4 **Description of Measurement**

The bandwidth was measured at an amplitude level reduced from the reference level of a modulated channel by a ratio of -6 dB. The reference level is the level of the highest signal amplitude observed at the transmitter at either the fundamental frequency or the first order modulation products in all typical modes of operation, including the unmodulated carrier, even if atypical. An alternative is to use the bandwidth measurement of the analyser.

Spectrum analyser settings: RBW: 100 kHz, VBW: 300 kHz. Detector: Peak.

Sweep time: 5 ms

The table below shows the settings according to ANSI C63.4:

Fundamental frequency	Minimum resolution bandwidth
9 kHz to 30 MHz	1 kHz
30 to 1000 MHz	10 kHz
1000 MHz to 40 GHz	100 kHz



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5.3 Occupied bandwidth

For test instruments and accessories used see section 6 Part MB.

5.3.1 Description of the test location

Test location: AREA4

5.3.2 Photo documentation of the test set-up



5.3.3 Applicable standard

According to RSS-Gen, 4.6.1:

When an occupied bandwidth value is not specified in the applicable RSS, the transmitted signal bandwidth to be reported is to be its 99 % emission bandwidth, as calculated or measured.

5.3.4 Description of Measurement

The bandwidth was measured with the function "bandwidth measurement" of the spectrum analyser. The EUT is connected via suitable attenuator at the spectrum analyser. The measurement is repeated for every different modulation standard of the EUT and recorded.

Spectrum analyser settings:RBW: 100 kHz,VBW: 300 kHz,

Detector: Sample detector, Sweep time: Auto



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5.4 Maximum peak conducted output power

For test instruments and accessories used see section 6 Part CPC 3.

5.4.1 Description of the test location

Test location: AREA4

5.4.2 Photo documentation of the test set-up



5.4.3 Applicable standard

According to FCC Part 15, Section 15.247(b)(3):

For systems using digital modulation in the 2400-2483.5 MHz and 5725 – 5850 MHz bands, the maximum peak output power of the transmitter shall not exceed 1 Watt. The limit is based on transmitting antennas of directional gain that do not exceed 6 dBi.

5.4.4 Description of Measurement

The maximum peak conducted output power is measured using a spectrum analyser with the function "RBW \geq DTS bandwidth" following the procedure set out in KDB 558074, item 9.1.1. The EUT is set in TX continuous mode while measuring.

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5.5 Power spectral density

For test instruments and accessories used see section 6 Part CPC 3.

5.5.1 Description of the test location

Test location: AREA4

5.5.2 Photo documentation of the test set-up



5.5.3 Applicable standard

According to FCC Part 15, Section 15.247(e):

For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission. This power spectral density shall be determined in accordance with the provisions of paragraph (b) of this section. The same method of determining the conducted output power shall be used to determine the power spectral density.

5.5.4 Description of Measurement

The measurement is performed using the procedure 10.2 set out in KDB-558074. The power measurement was done using the integrated band power method. Therefore the PKPSD is measured. The max peak was located and with the spectrum analyser and a marker set to peak. The attenuator or cable losses are taken into account with an amplitude offset.

Spectrum analyser settings: RBW: 3 kHz, VBW: 10 kHz,

Detector: Peak,

Sweep time: auto,



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5.7 Band edge compliance

For test instruments and accessories used see section 6 Part MB.

5.7.1 Description of the test location

Test location: AREA4

5.7.2 Photo documentation of the test set-up



5.7.3 Applicable standard

According to FCC Part 15C, Section 15.247(d):

In any 100 kHz bandwidth outside the frequency bands 2400 – 2483.5 MHz and 5725 – 5850 MHz, the digitally modulated radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or an radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.

5.7.4 Description of Measurement

A spectrum analyser is connected to the output of the transmitter via a suitable attenuator while EUT was operating in transmit mode at the assigned frequency according Publication Number 913591, 03/26/2007.

Spectrum analyser settings:RBW: 100 kHz,VBW: 300 kHz,Detector: Max peak,Trace: Max hold,Sweep: auto



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5.8 Spurious emissions in restricted bands (conducted)

For test instruments and accessories used see section 6 Part SEC 2, SEC 3.

5.8.1 Description of the test location

Test location: AREA4

5.8.2 Photo documentation of the test set-up



According to FCC Part 15, Section 15.205(a):

In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limit specified in Section 15.209(a).

5.8.3 Description of Measurement

The restricted bands are measured conducted. The span of the spectrum analyser is set wide enough to capture the restricted band and measure the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation. The restricted bands are measured falling emissions into it and the nearest restricted band are checked for emissions also the restricted band for the harmonics of the carrier.

Spectrum analyser settings:

RBW: 1 MHz, VBW: 3 MHz,

Sweep: Auto,

Detector function: Peak



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5.9 Radiated emissions (Cabinet radiation)

For test instruments and accessories used see section 6 Part SER 2, SER 3.

5.9.1 Description of the test location

Test location:	OATS 1
Test location:	Anechoic chamber 1

Test distance: 3 m

5.9.2 Photo documentation of the test set-up



Anechoic chamber 1





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5.11 Correction for pulse operation (duty cycle)

For test instruments and accessories used see section 6 Part DC.

5.11.1 Description of the test location

Test location: AREA4

5.11.2 Photo documentation of the test set-up



5.11.3 Applicable standard

According to FCC Part 15A, Section 15.35(c):

When the radiated emission limits are expressed in terms of average value and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete puls train, including blanking intervals, as long as the pulse train does not exceed 0.1s. In cases where the puls train exceeds 0.1s, the measured field strength shall be determined from the average absolute voltage during a 0.1s interval during which the field strength is at its maximum. The exact method of calculating the average field strength shall be submitted.

5.11.4 Description of Measurement

The duty cycle factor (dB) is calculated applying the following formula:

$$K_{E} = 20 \log \frac{(t_{iW}/T_{B}) * t_{iB}}{T_{W}}$$

Where:

- KE = pulse operation correction factor
- tiw = pulse duration for one complete pulse track
- tiB = pulse duration for one pulse
- T_w = a period of the pulse track
- T_B = a period of one pulse

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